

Notice of References Cited

Application/Control No.

10/015,564

Applicant(s)/Patent Under

Reexamination
KUTSUNA ET AL.

Examiner

Christopher M. Keehan

Art Unit

1712

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	0709418A2	05-1996	EP	Kihara et al.	
	O					
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NON-PATENT DOCUMENTS

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